


<b>Search Notes</b>  	<b>Application/Control No.</b>  10524587	<b>Applicant(s)/Patent Under Reexamination</b>  SERNA ET AL.
	<b>Examiner</b>  Pablo N Tran	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
370	390,, 392,, 252, 256, 310-313, 329-331, 347-349, 352, 390-392, 395.52, 428, 432, 341, 409, 437	8/16/10	PT

SEARCH NOTES		
Search Notes	Date	Examiner
East/West	8/16/10	PT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Pablo N Tran/ Primary Examiner.Art Unit 2618
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